

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/091,919 | Applicant(s)/Patent Under Reexamination CHOY ET AL. | |
| | Examiner Kuen S. Lu | Art Unit 2167 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,078,926 | 06-2000 | Jensen et al. | 707/103R |
| * | B | US-6,732,331 | 05-2004 | Alexander, Vlad | 715/513 |
| * | C | US-5,913,205 | 06-1999 | Jain et al. | 707/2 |
| * | D | US-2001/0052032 | 12-2001 | Williamson et al. | 709/315 |
| * | E | US-5,907,846 | 05-1999 | Berner et al. | 707/103R |
| * | F | US-6,405,205 | 06-2002 | Hakuba, Tomohiro | 707/101 |
| * | G | US-6,647,396 | 11-2003 | Parnell et al. | 707/102 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.